



Printed Pages : 3

EC – 201

(Following Paper ID and Roll No. to be filled in your Answer Book)

PAPER ID : 3035

Roll No.

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B. Tech.

(SEM. II) EXAMINATION, 2006-07

BASIC ELECTRONICS

Time : 2 Hours]

[Total Marks : 50

- Note :*
- (1) All questions are **compulsory**.
 - (2) Assume suitable data wherever **necessary**.

1 Answer any **four** of the following : **3.5×4=14**

- (a) Define resistivity, bulb resistance and ohmic contact resistance.
- (b) In an n-type Si, the fermi level is 0.3 eV. below the conduction band edge. Find the electron and hole concentrations in Si at room temperature (300 K) (for Si, $E_g = 1.1\text{eV}$, $n_i = 1.5 \times 10^{10}$ per cm^3 and $h = 8.62 \times 10^{-5}$ eV/K).
- (c) Assuming $n = ND^+$ show that at very low temperatures, the Fermi level in an n-type semiconductor is given

$$\text{by } E_F = \frac{E_c + E_D}{2} - \frac{KT}{2} \ln \left(\frac{2 N_C}{N_D} \right)$$

- (d) Differentiate between direct and indirect semiconductors.

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- (e) The intrinsic carrier concentration for Si at room temperature is $1.5 \times 10^{10} \text{ cm}^{-3}$. The electron mobility for intrinsic silicon is $1350 \text{ cm}^2/\text{Vs}$ and hole mobility is $480 \text{ cm}^2/\text{Vs}$. Calculate the resistivity of intrinsic Si at room temperature.
- (f) Show that L_p is the average distance travelled by diffusing carriers before they recombine. The variable L_p represents the distance at which the excess hole concentration falls to $1/e$ of its value at the point of injection of an n-type semiconductor, (all notations carry standard meaning)

2 Answer any **three** of the following : **5×3=15**

- (a) The FB junction of an npn transistor is forward biased by VBF while the collector terminal is left open. What is the value of VCE at this point?
- (b) Derive formula for transistor power dissipation. Obtaining this relationship where on the load line you would expect the power dissipation to the maximum?
- (c) Describe the differences between r_e and hybrid equivalent model for a BJT.
- (d) Derive the expressions for stability of BJT amplifiers.
- (e) When a transistor is in saturation and I_B is fixed, show that for small values of V_{CE} ($< 0.2\text{V}$), V_{BE} increases and V_{BC} reduces with increase in V_{CE} .

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3 Answer any **three** of the following : **4×3=12**

- (a) Convert binary numbers 10111011 and 1101.0110111 into octal numbers.
- (b) Convert 3F29 hexadecimal to its decimal equivalent.
- (c) What are open-collector gates? Explain.
- (d) Elucidate universal gates with the help of suitable example.
- (e) How bases are converted in number systems? What will be 2's complement representation of decimal – 14 into its equivalent hexadecimal?

4 Answer any **two** of the following : **4.5×2=9**

- (a) Explain, how does the frequency of the input signal to an op.amp affects voltage gain.
- (b) Explain chopped and alternate methods of trace development of CROS. How many cycles of a 2-kHZ sinusoidal signal are viewed if the sweep frequency is 1kHZ.
- (c) Draw circuit diagram of a multimeter and explain its operation in detail.
